

Search Notes

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Examiner

Hai V. Nguyen

Applicant(s)/Patent under
Reexamination

KOBAYASHI ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
358	1.14	9/26/2006	HN
358	1.15		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search updated	9/26/2006	HN